

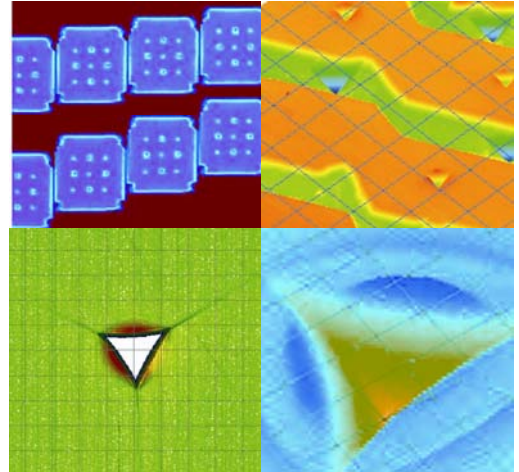


Advanced Techniques in Nanomechanical Measurements Seminar

Hosted by: Prof. Jeffrey Kysar

When: Friday, April 10 @ 11:00
am

Where: 337 Mudd Bldg.



Agilent Technologies invites you to attend a special seminar focused on advanced techniques in Nanomechanical measurements. Come learn about methods for mechanical probing of MEMS and the materials used in these fine structures. The seminar will present applications spanning accelerometer membranes and semiconductor circuit probes.

An Agilent application scientist will be on hand to share insights on the measurement routines that may be applied to complex mechanical problems at the nano and micro-scales. Demonstration of the latest methods and discussion of non-traditional uses of nanoindentation platforms will take place after the seminar.